Notice of References Cited

	Application/Control No.	Applicant(s)/Pater	nt Under
	10/522,720	Reexamination KAWAKAMI, TAK	ASHI
	Examiner	Art Unit	
I	HENOK G. HEYI	2627	Page 1 of 1

U.S. PATENT DOCUMENTS

	C.G. PATERT DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,226,672 B1	05-2001	DeMartin et al.	709/219
*	В	US-6,542,445 B2	04-2003	ljichi et al.	369/30.08
*	O	US-2004/0213552 A1	10-2004	Kato, Motoki	386/069
*	D	US-2005/0273632 A1	12-2005	Kawakami, Takashi	713/193
*	Е	US-7,130,251 B1	10-2006	Morohashi, Akihiro	369/47.13
	F	US-			
	G	US-		-	
	Н	US-		-	
	-	US-			
	7	US-			
	К	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003029795 A	01-2003	Japan	SAWAI, MASAHARU	G10L 19/00
	0					
	Р					
	Q					
	R					
	s					
	т					

NON-PATENT DOCUMENTS

*	* Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
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	w			
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"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.